

Search Notes

Application/Control No.

10/073,636

Examiner

Annan Q. Shang

Applicant(s)/Patent under
Reexamination

AVISON, BEN

Art Unit

2623

SEARCHED

| Class | Subclass | Date | Examiner |
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| 725 | 87-90,102 | 7/2/2007 | A.S |
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INTERFERENCE SEARCHED

| Class | Subclass | Date | Examiner |
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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

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